

# **Surface Layer Characterization of Atomized Magnesium for use in Powder Metallurgy Products**

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# Outline

- Introduction
- Background
- Surface Contaminants
- Mg Surface Contaminants
- Mg Sintering Strategies
- Future Work
- Acknowledgments



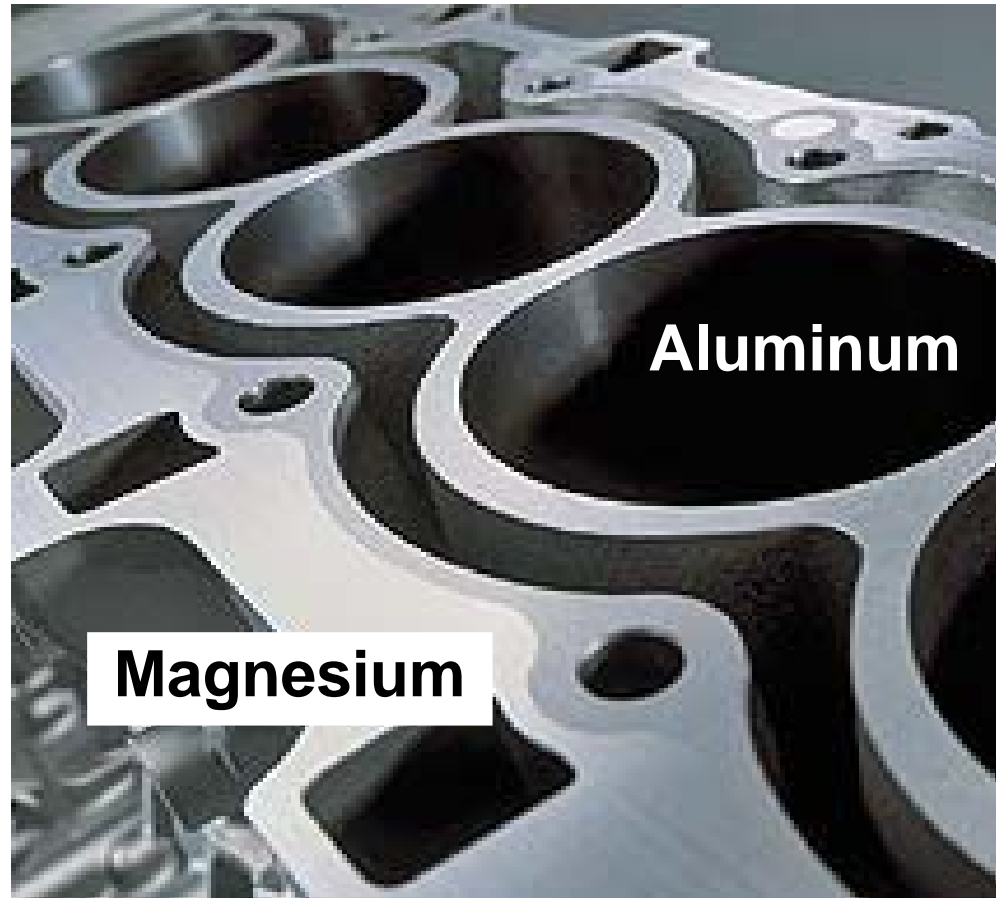
# Introduction

## Benefits of Magnesium

- High stiffness to weight ratio
- High damping capacity
- Recyclable

## Issues with Magnesium

- Lack of developed alloys
- Difficult forming
- Corrosion

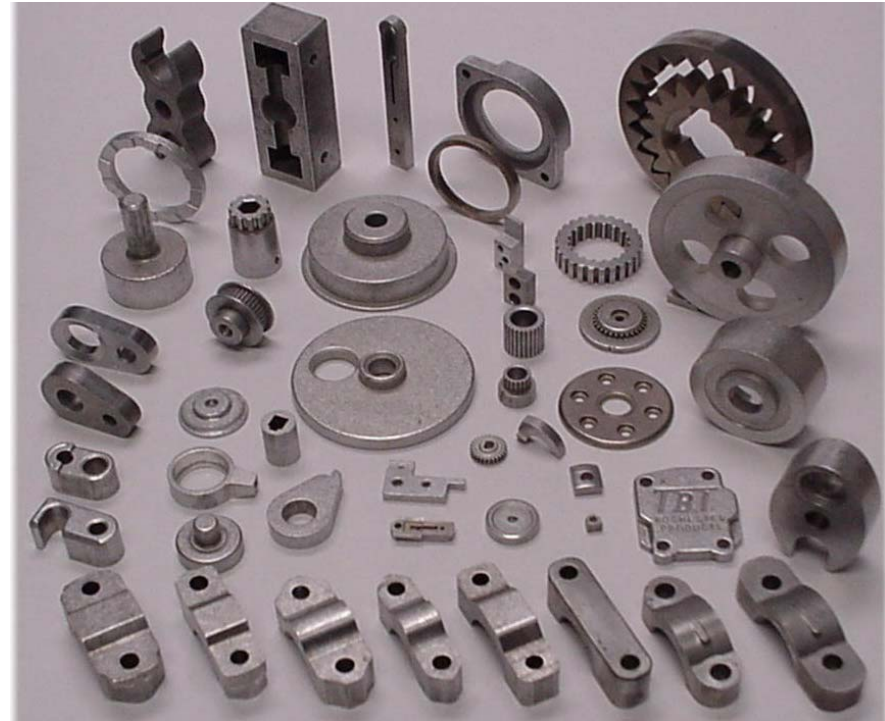




# Introduction

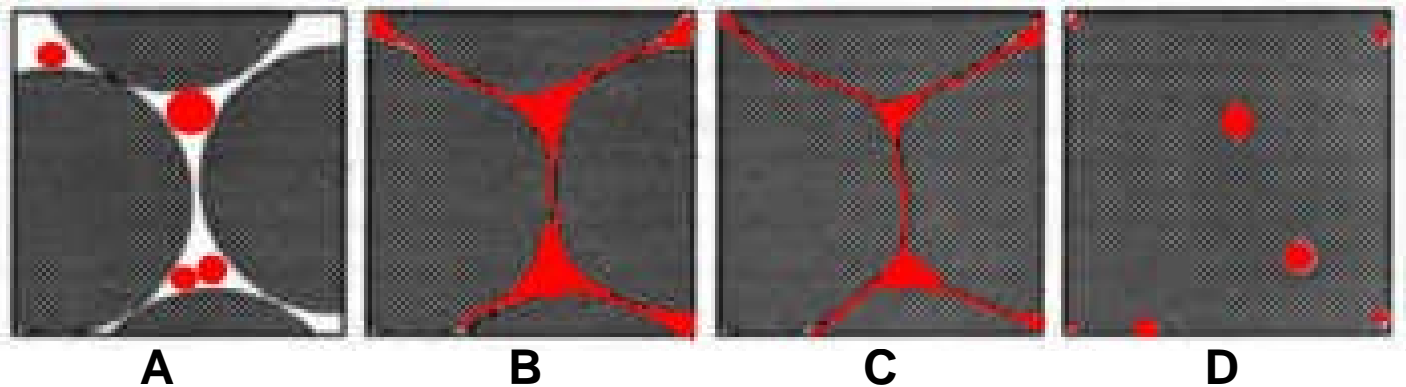
## Powder Metallurgy

- Powder metal feedstock
- Compacted at high pressure in specially shaped die
- Sintered at temperature below melting
- Near-net shape parts
- Mg P/M largely unexplored

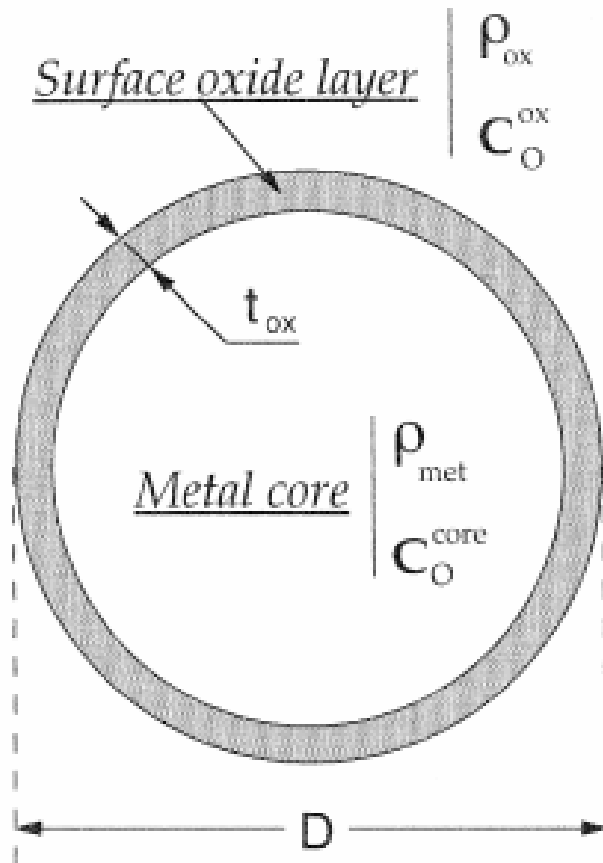


# Sintering of Metal Powders

- Stages of sintering
  - » Point contact (A)
  - » Initial stage (B)
  - » Intermediate stage (C)
  - » Final stage (D)



# Surface Contaminants on Metal Powders



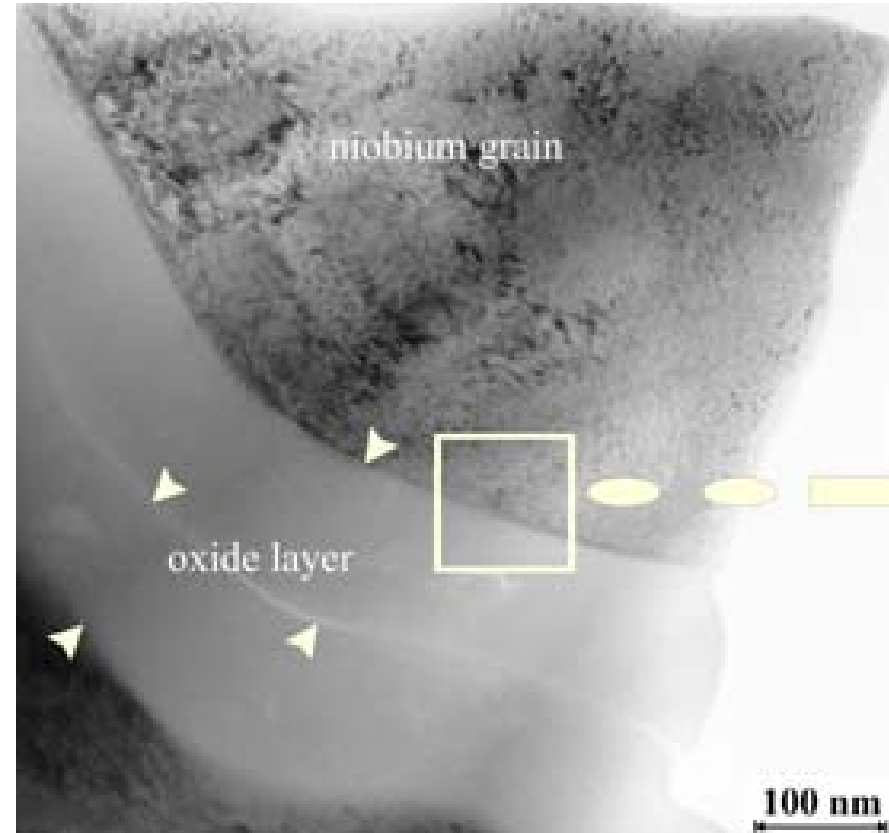
- Metal core
- Surface layer
  - Oxide?
  - Hydroxide?
  - Carbonate?
  - Thickness?

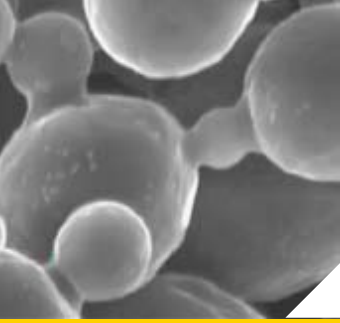




# Surface Contaminants

- Characterizing surface layer
  - Auger electron spectroscopy (AES)
  - X-ray photoelectron spectroscopy (XPS) →
  - Secondary ion mass spectroscopy (SIMS)
  - Transmission electron microscopy (TEM) →

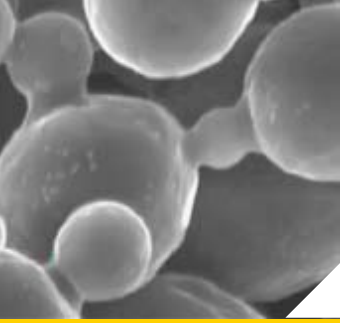




# Surface Contaminants and Sintering

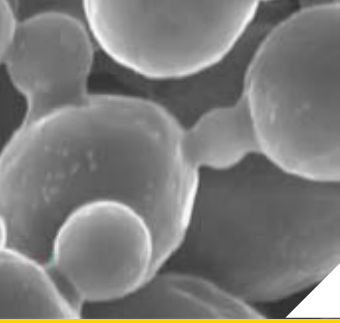
- Dealing with the surface layer
  - Dissolve layer into metal
  - Diffuse metal through layer
  - Thermo-chemical reduction





# Surface Contaminants and Sintering

- **Dissolve layer into metal**
  - Depends on oxygen solubility in metal
  - Sintering preceded by incubation period
    - Fe ~10 seconds
    - Al ~ 100+ days (Estimate)
    - Mg ~100+ days (Estimate)

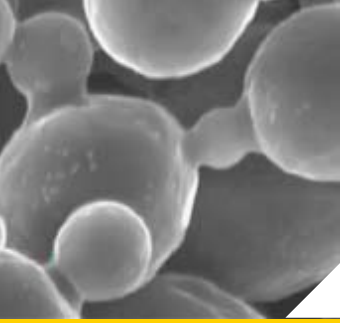


# Surface Contaminants and Sintering

- **Diffuse metal through layer**
  - Depends on diffusion rates and layer thickness

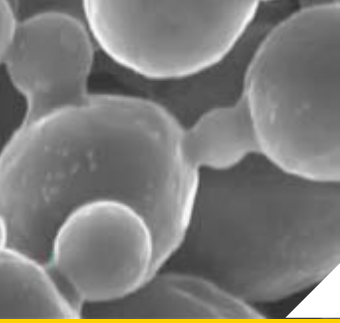
	$D_M$ $\text{m}^2 \text{sec}^{-1}$	$D_{\text{Ox}}$ $\text{m}^2 \text{sec}^{-1}$
<b>Cu</b>	$5.65 \times 10^{-13}$	$6.65 \times 10^{-12}$
<b>Al</b>	$1.84 \times 10^{-12}$	$5.51 \times 10^{-30}$
<b>Mg</b>	$3.01 \times 10^{-12}$	$5.25 \times 10^{-24}$





# Surface Contaminants and Sintering

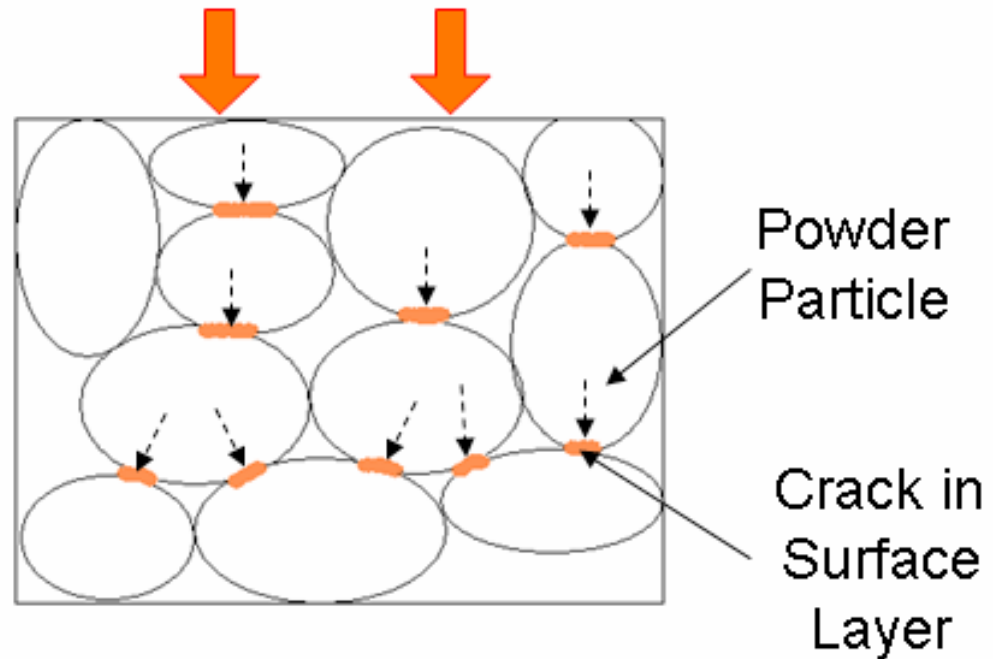
- **Thermo-chemical reduction**
  - Free energy diagram
  - Appropriate temperature, pressure and atmosphere
  - Addition of more reactive metal (Mg in Al)



# Surface Contaminants and Sintering

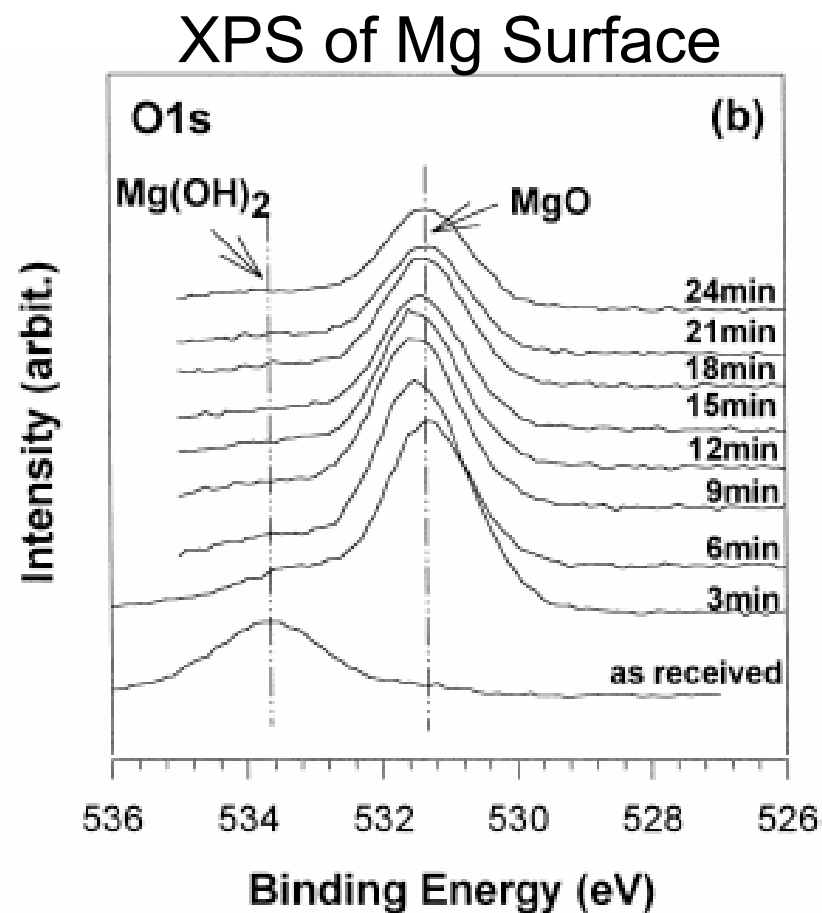
- **Break layer**

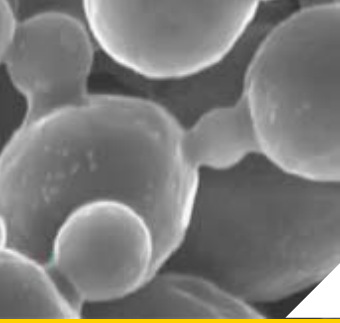
- Create short-circuit pathway for diffusion through cracks in layer
- Accomplished mechanically or chemically



# Mg Surface Contaminants

- When exposed to air, MgO forms with  $\text{Mg}(\text{OH})_2$  on the surface
- Thickness depends on exposure time
  - 1 min, 2.65 nm
  - 7 days, 5.31 nm
  - 7 years, 5.67 nm

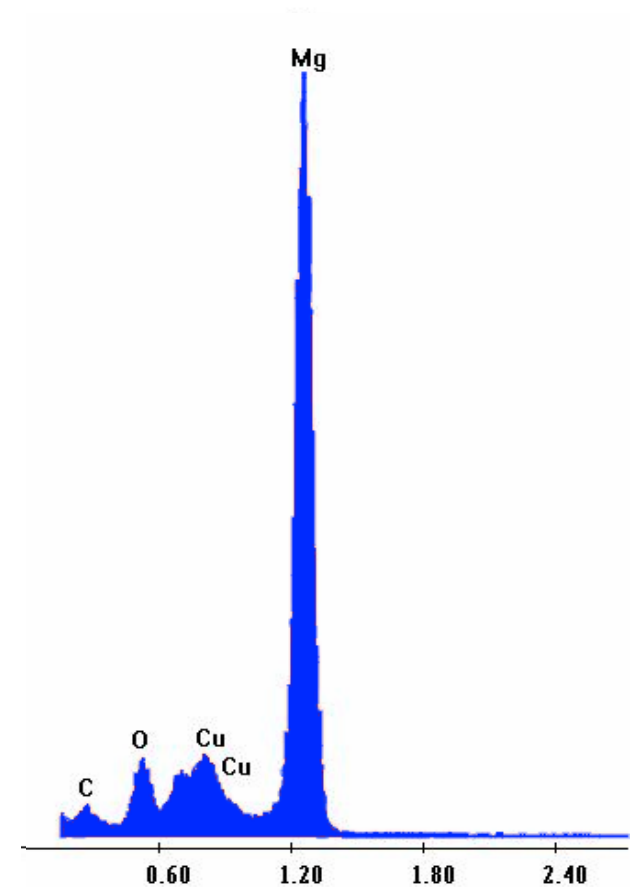
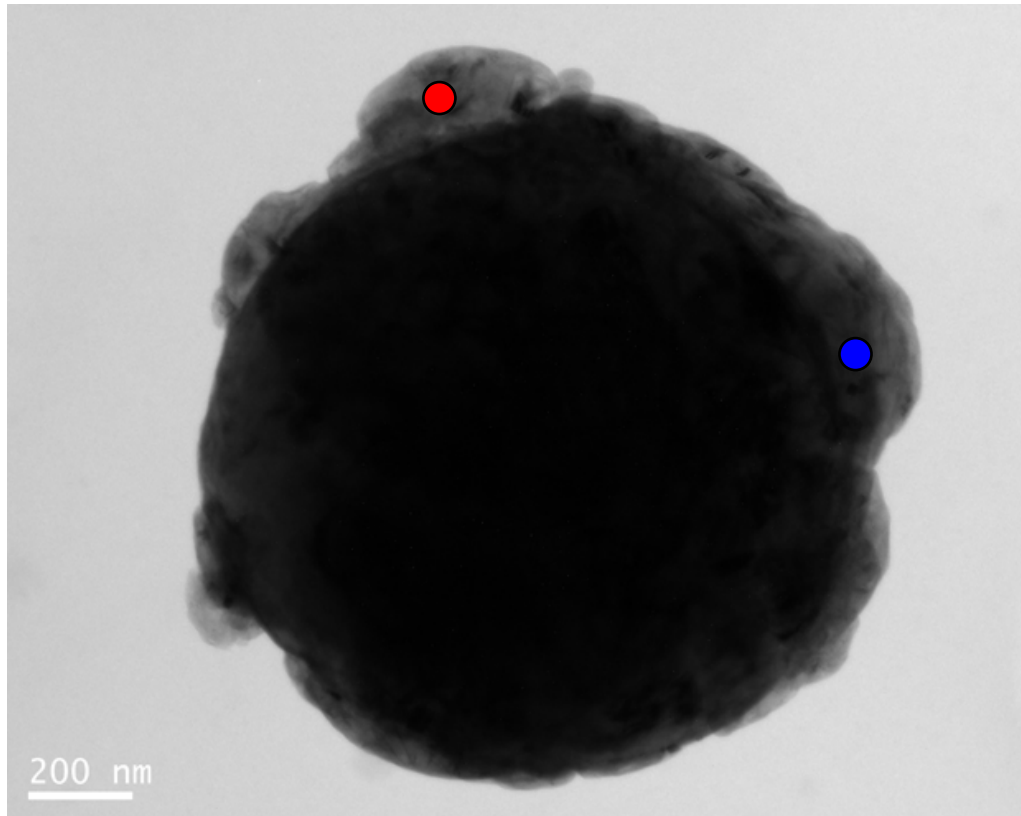




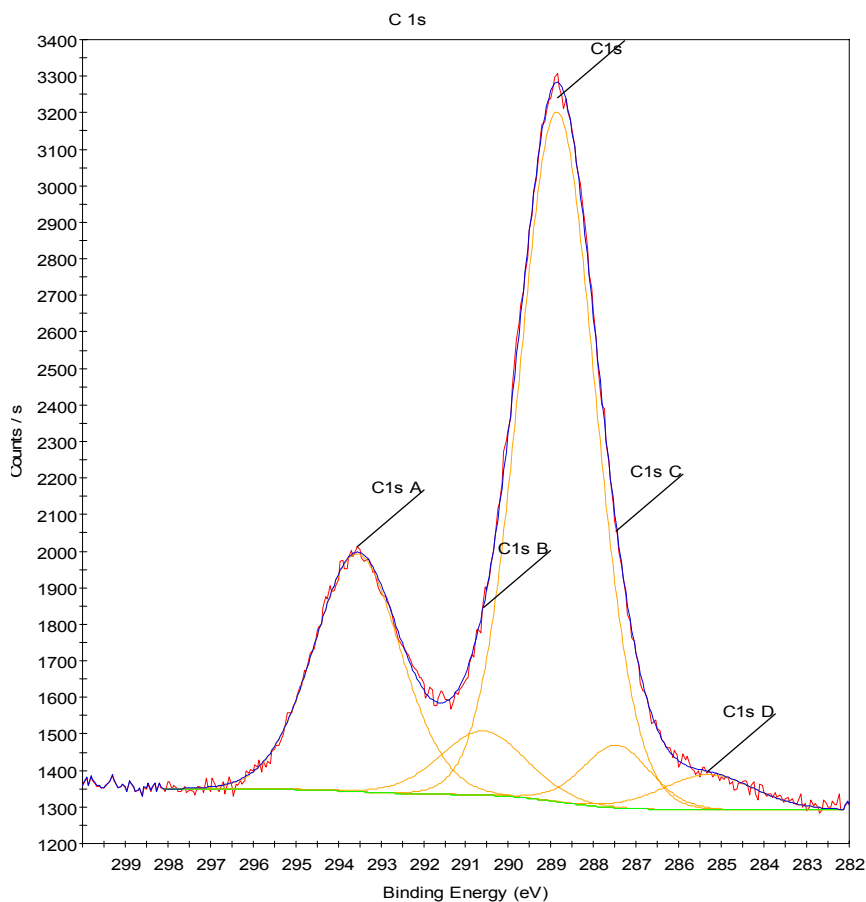
# Research Objective

- Fundamentals of magnesium sintering
  - Composition and thickness of surface layer by AES, XPS, SIMS, FIB/TEM
  - Decomposition reactions during sintering by DSC, DTA, TGA
- Practical strategies to aid sintering and mechanical properties

# Mg Atomized Powder Surface Contaminants (TEM)



# Mg Atomized Powder Surface Contaminants (XPS)



XPS identified that the  
surface contained:

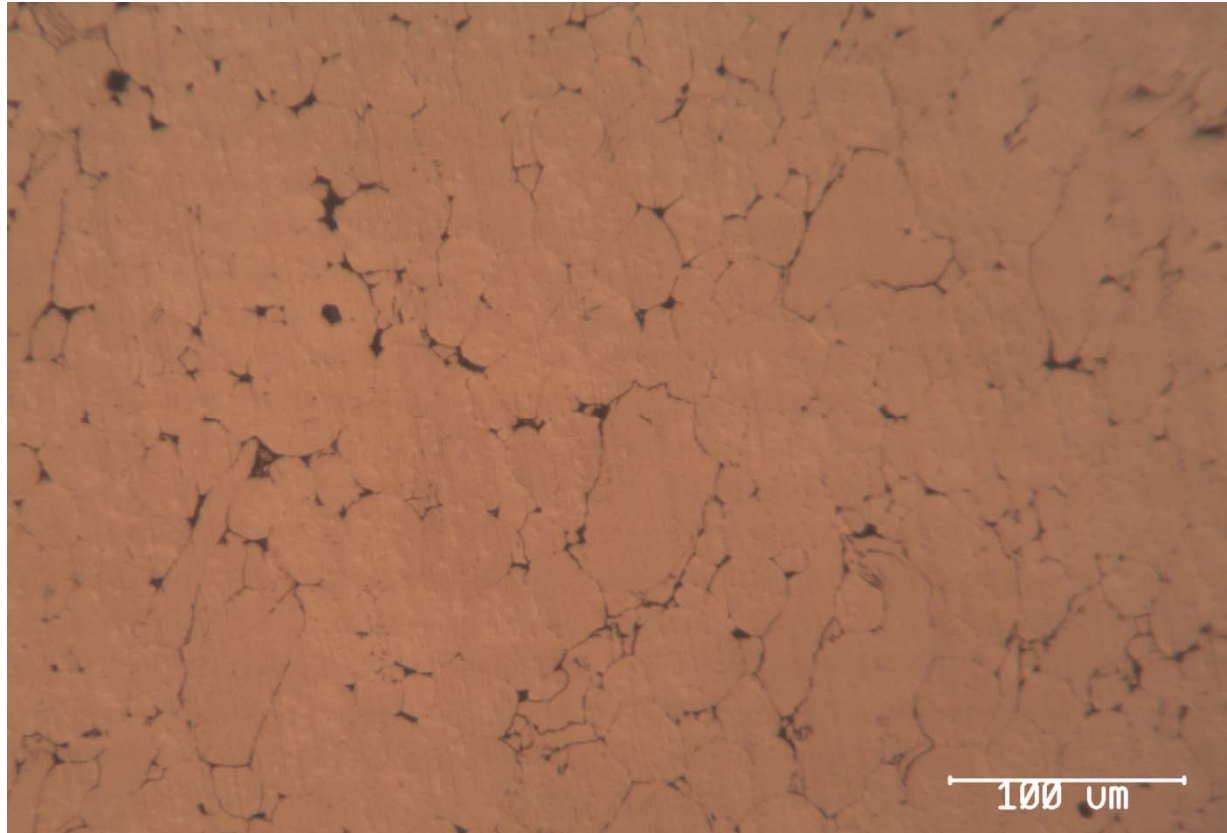
- Magnesium
- Oxygen
- Carbon





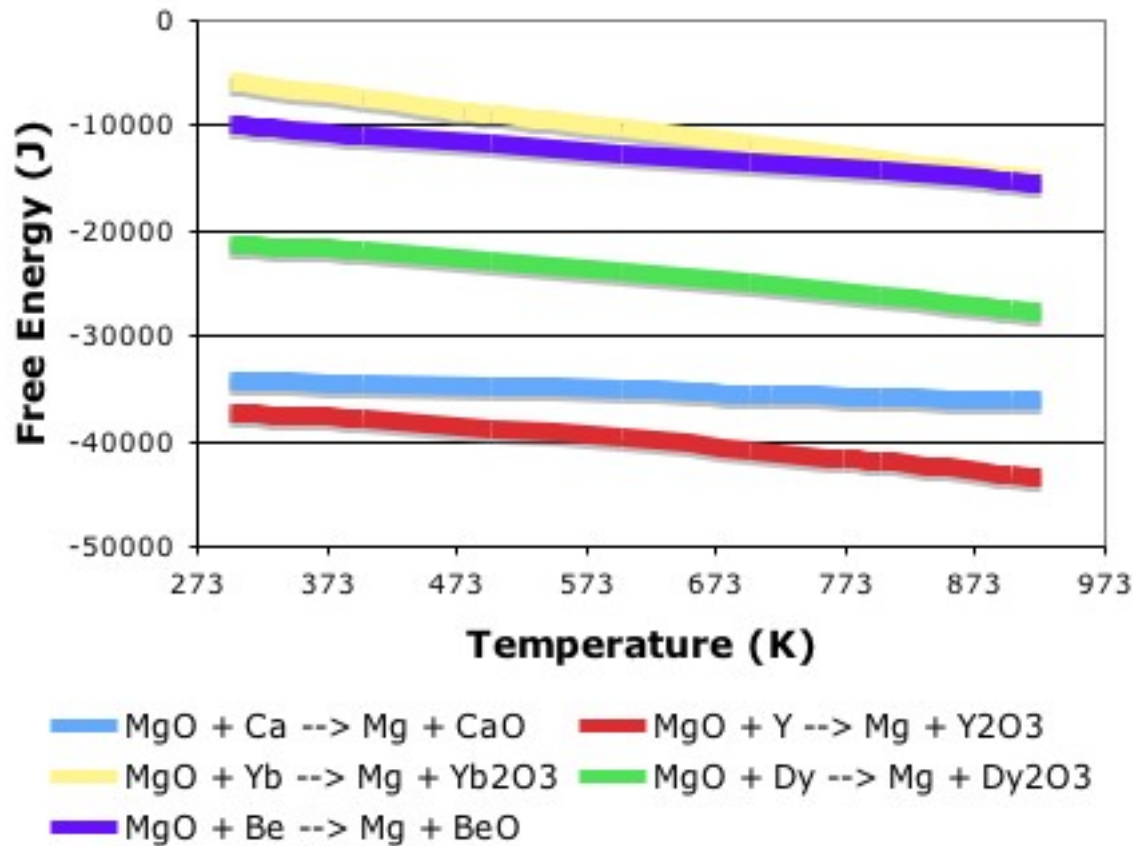


# Mg Sintering Strategies (Increased sintering time)



- Pure Mg
- 600°C
- 6 hours
- 40 min

# Mg Sintering Strategies (Thermo-chemical reduction)



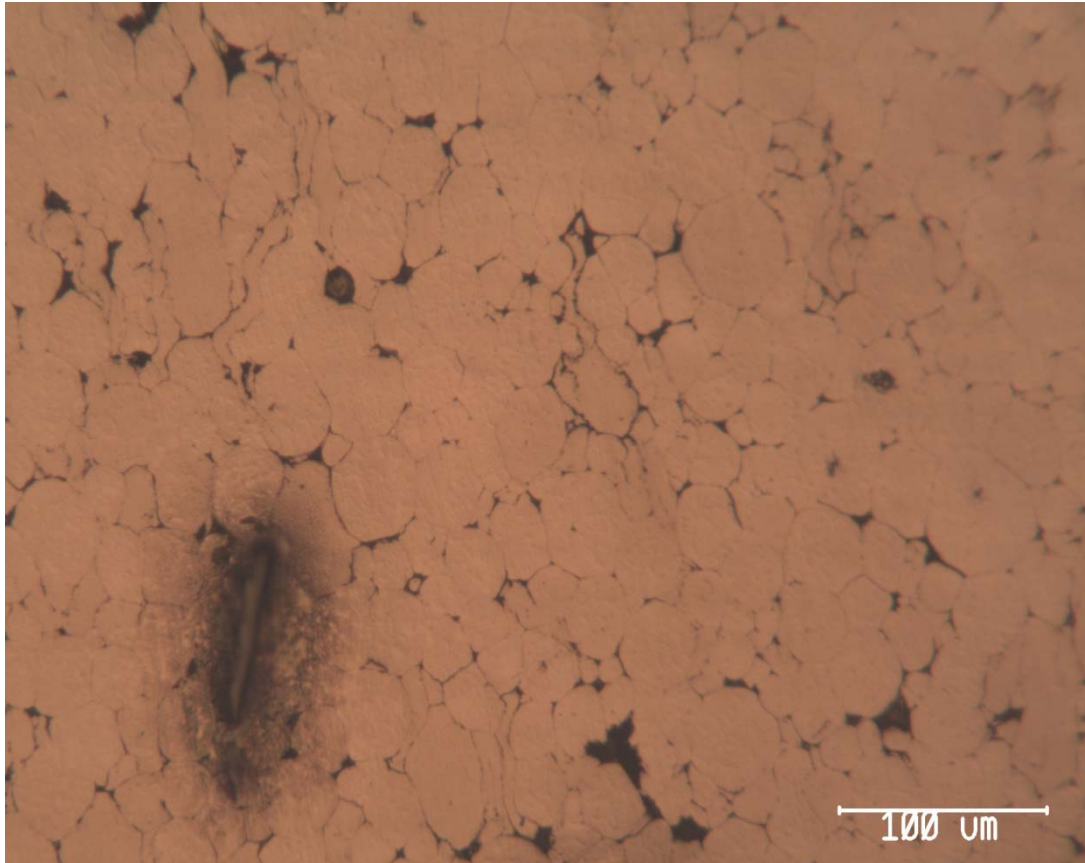
Elements with more stable oxides:

- Yb
- Be
- Dy
- Ca
- Y





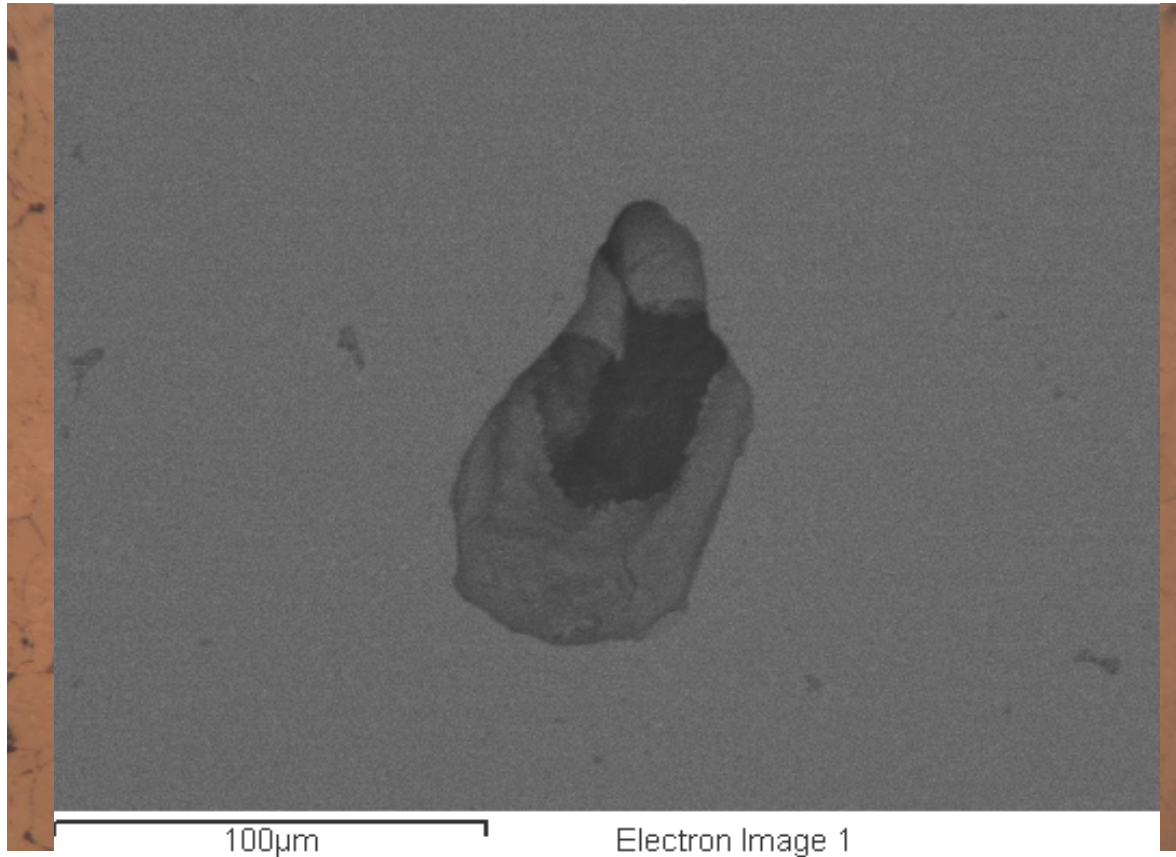
# Mg Sintering Strategies (Thermo-chemical reduction)



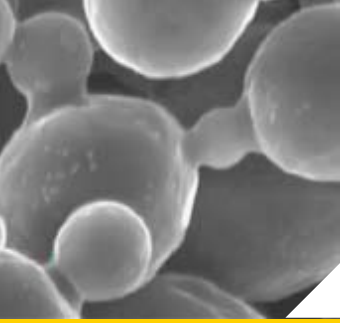
- 1 wt% Y
- 600°C
- 40 min



# Mg Sintering Strategies (Thermo-chemical reduction)

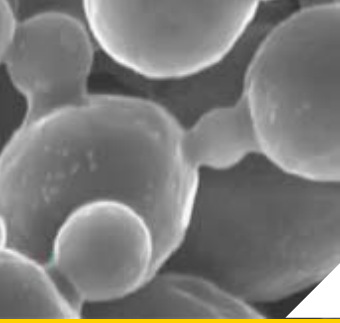


- 1 wt% Ca
- 600°C
- 40 min



# Mg Sintering Strategies (Post Sintering Forging)

- Samples of 95% or greater density will withstand hot or cold rolling to further increase density
  - 50% cold reduction, 150% hot reduction
  - Density increases near theoretical
  - Large increase in hardness



# Mg Sintering Strategies (Sintering Atmosphere)

- Compacts can be sintered in argon or nitrogen
- During sintering, gas can become trapped as porosity closes
  - Argon completely inert, pressure inside pore prevents densification
  - Nitrogen may react, reducing pressure inside pore





# Mg Sintering Strategies (Powder Pre-Treatment)

- Before processing, Mg powder can be dipped with a solution designed to dissolve the surface layer
  - Acids, bases, organic compounds possible
  - Difficulty arises when solution comes into contact with fresh Mg surface



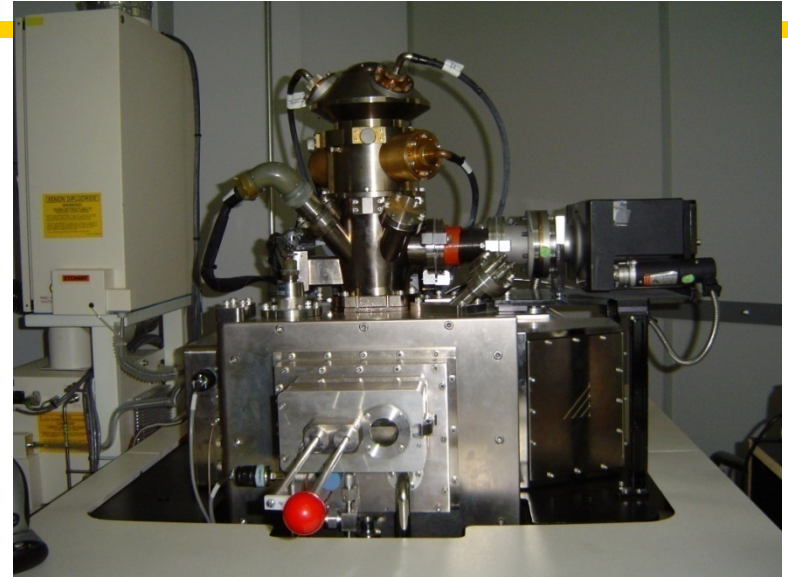
# Experiment for FIB/TEM

- Expose Mg powder ( $\sim 50\text{ }\mu\text{m}$ ) to air:
  - One day
  - Two days
  - Five days
  - Seven days
- Examination by FIB/TEM/EDS.
  - Avoid:
    - Water, oxygen
    - Organic solvent
    - Destruction of film

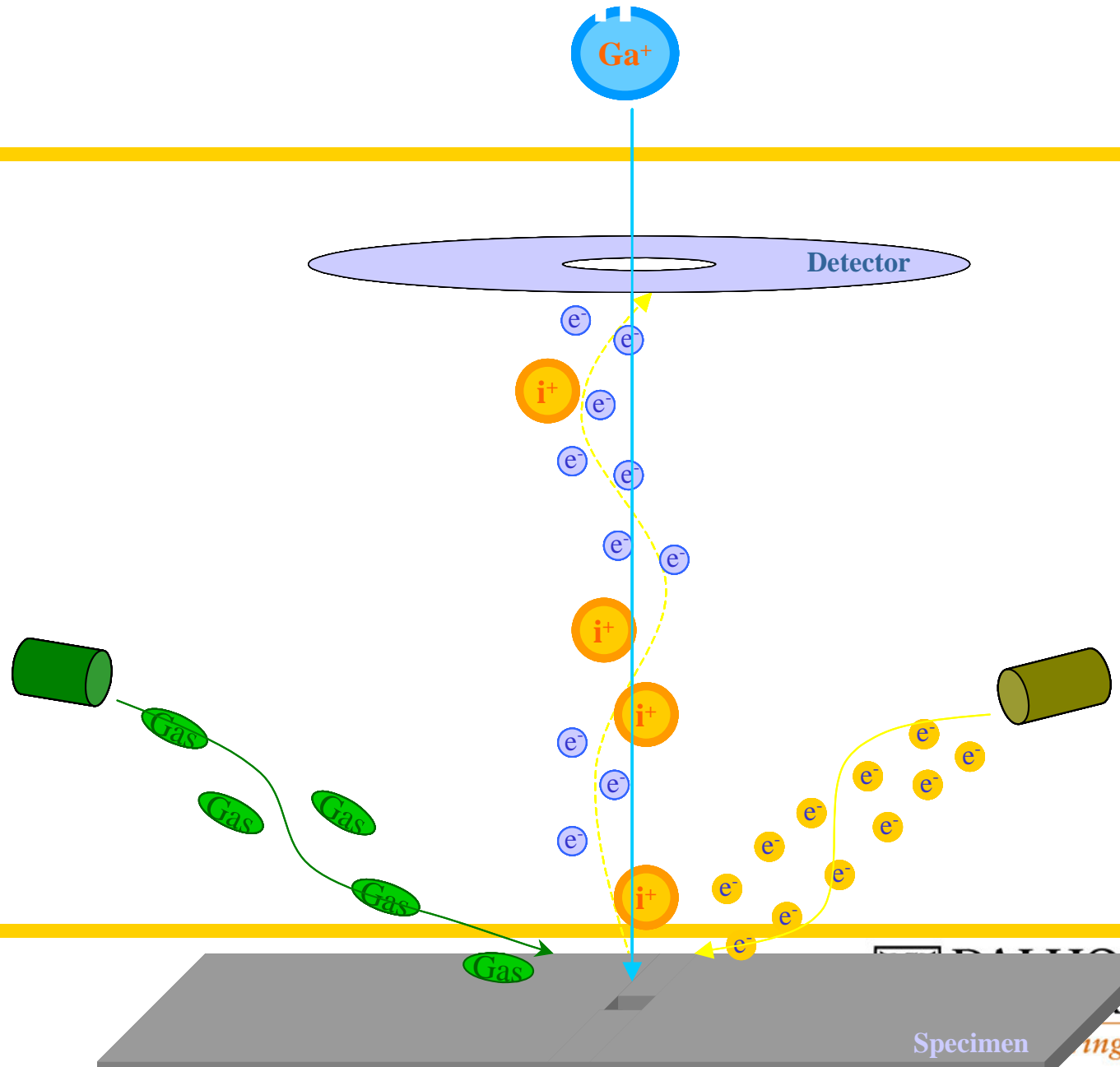
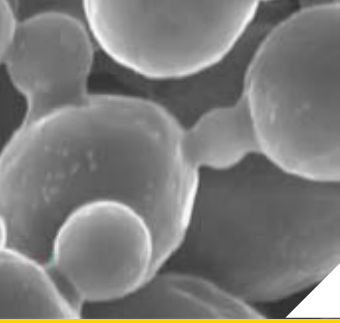




# A Micrion-2500 Single Beam FIB System



- 5 nm imaging resolution using a focused Ga ion beam.
- Beam current ranges from 1 pA to 40 nA.
- “Stress free” site specific cross-sectioning and imaging.
- Gas assisted etching and precise metal and oxide deposition.
- Secondary electron (SE) and secondary ion imaging.





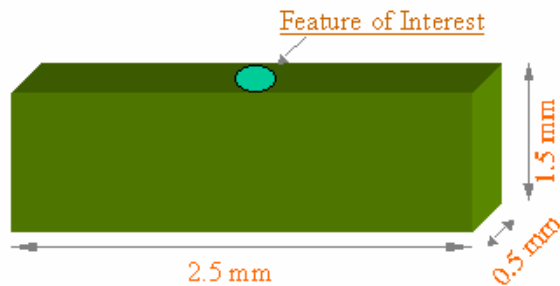
# Focused Ion Beam (FIB) Microscopy

- The FIB microscopes were developed in the early 1980s. It has been widely implemented in the semiconductor industry as semiconductor device modification, device failure analysis.
- In recent years, FIB found many applications in materials studies.
- Typical materials science applications include:  
**Stress-free ion beam cross-sectioning and high-resolution ion beam imaging, site-specific TEM specimen preparation, micro-machining and micro-deposition.**

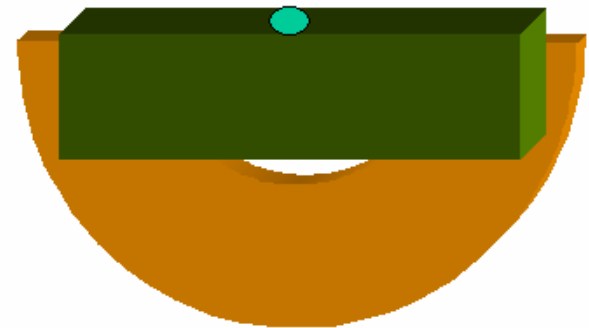
# FIB TEM Sample Preparation Techniques

## Traditional H-bar technique

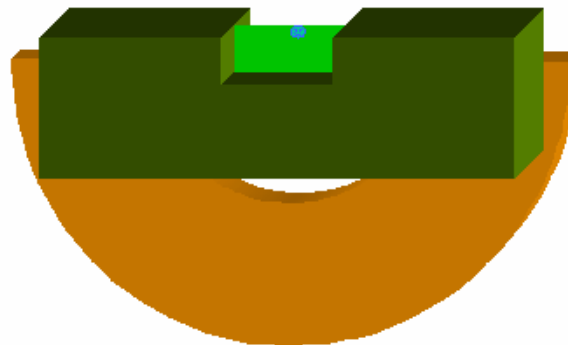
Small sample cut out from bulk using a diamond saw



Sample mounted on a TEM grid  
After carefully polished by a tripod polisher



FIB thinning to create an electron transparent area





# Lift-out FIB TEM Sample Preparation Technique

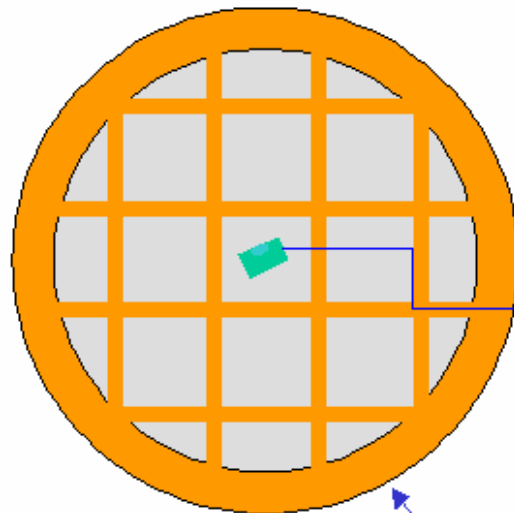
Membrane containing feature of interest FIB thinned to about 100 nm and cut free from the bulk



Thin membrane "lift-out" by a micro-manipulator

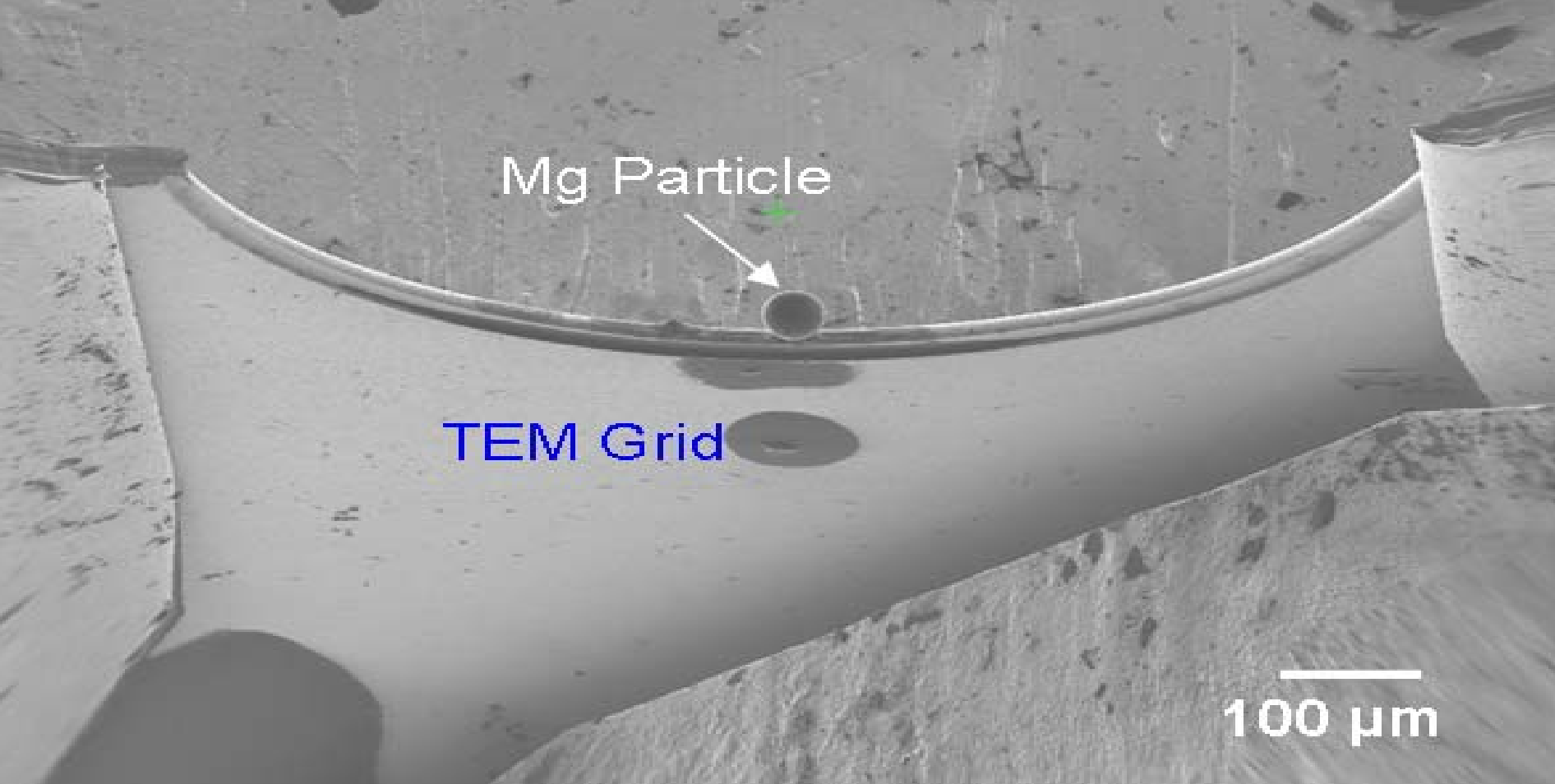


Micro-manipulator system



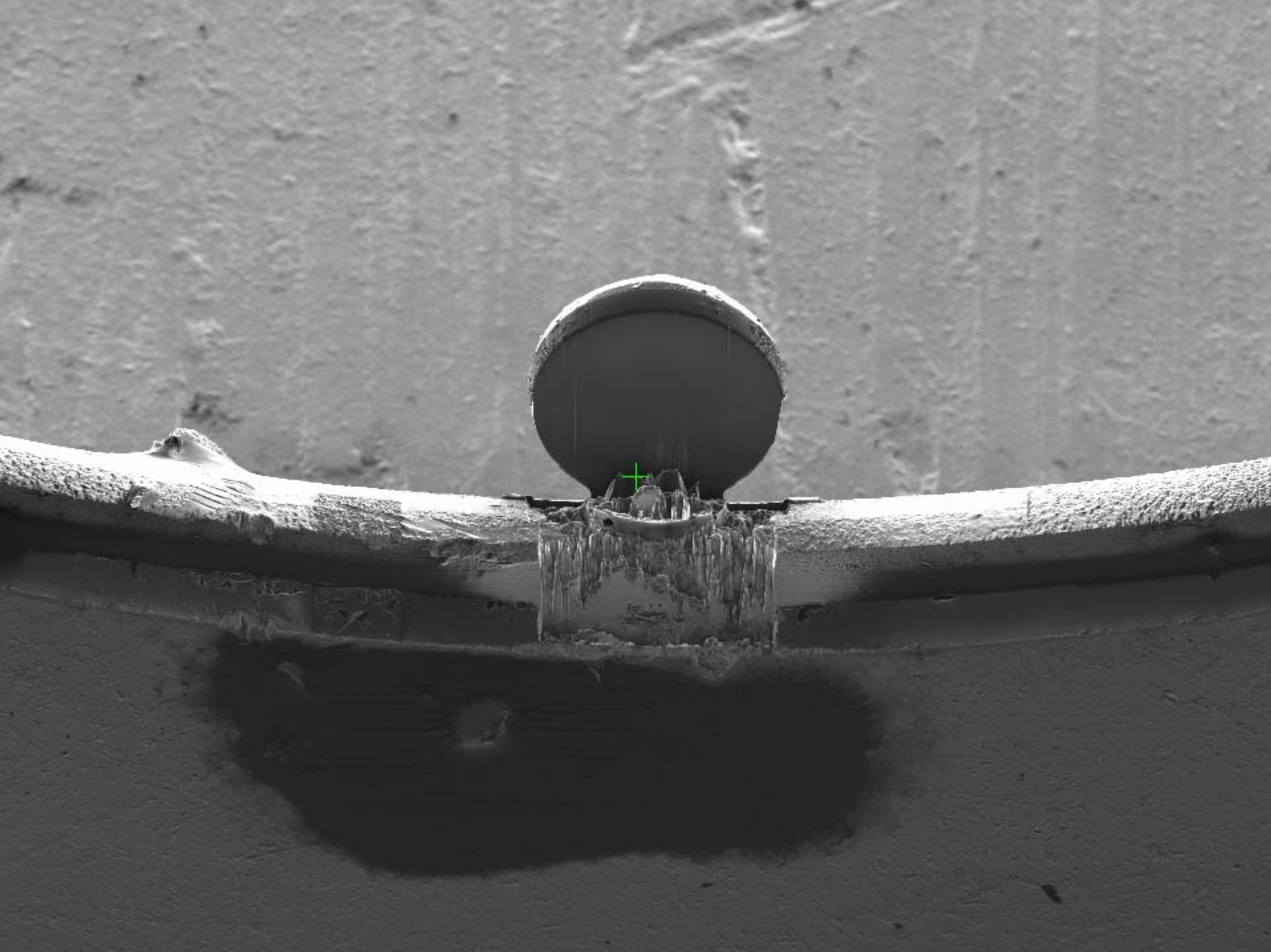
Electron transparent sample prepared by FIB

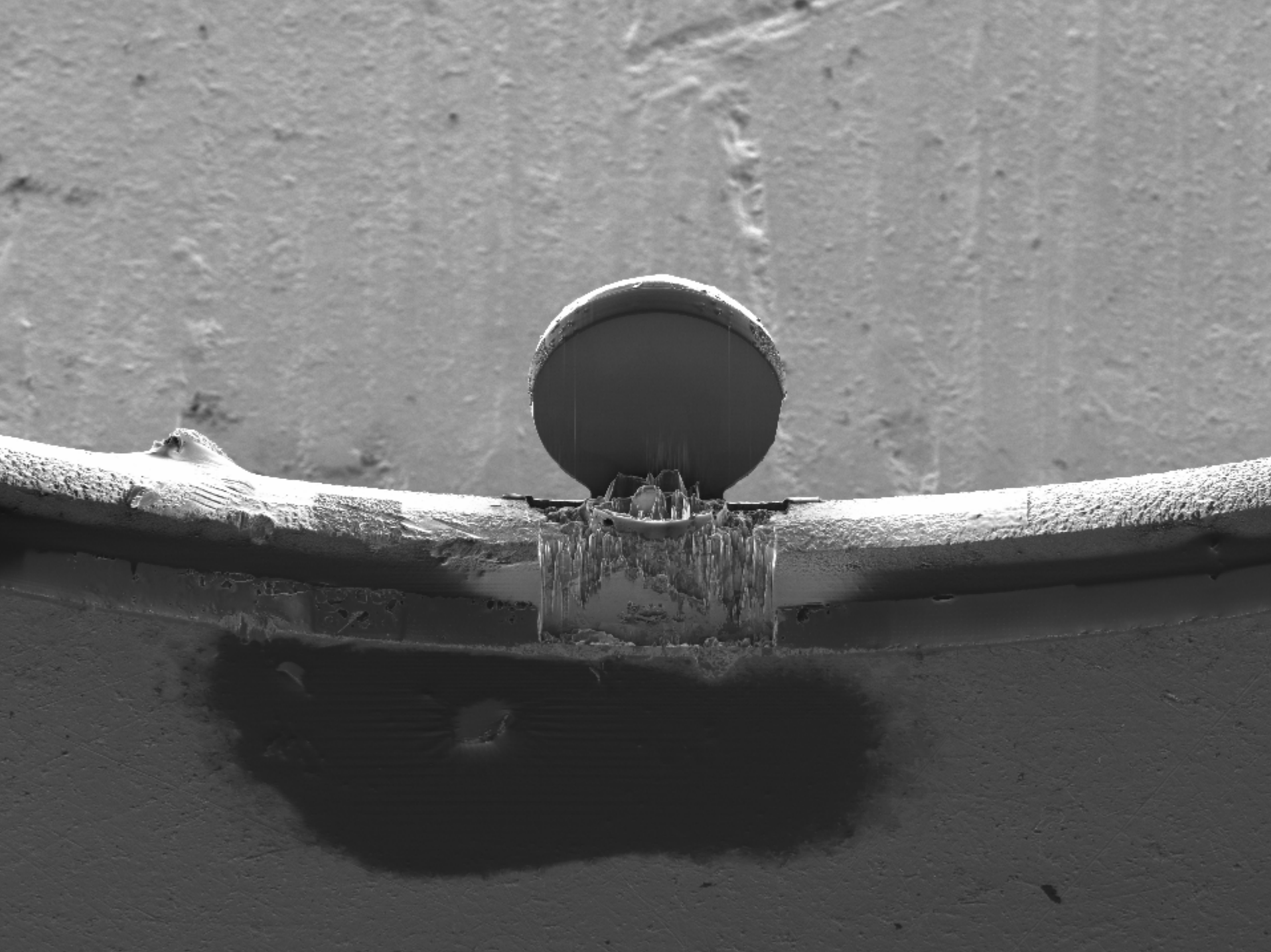
3mm diameter TEM grid



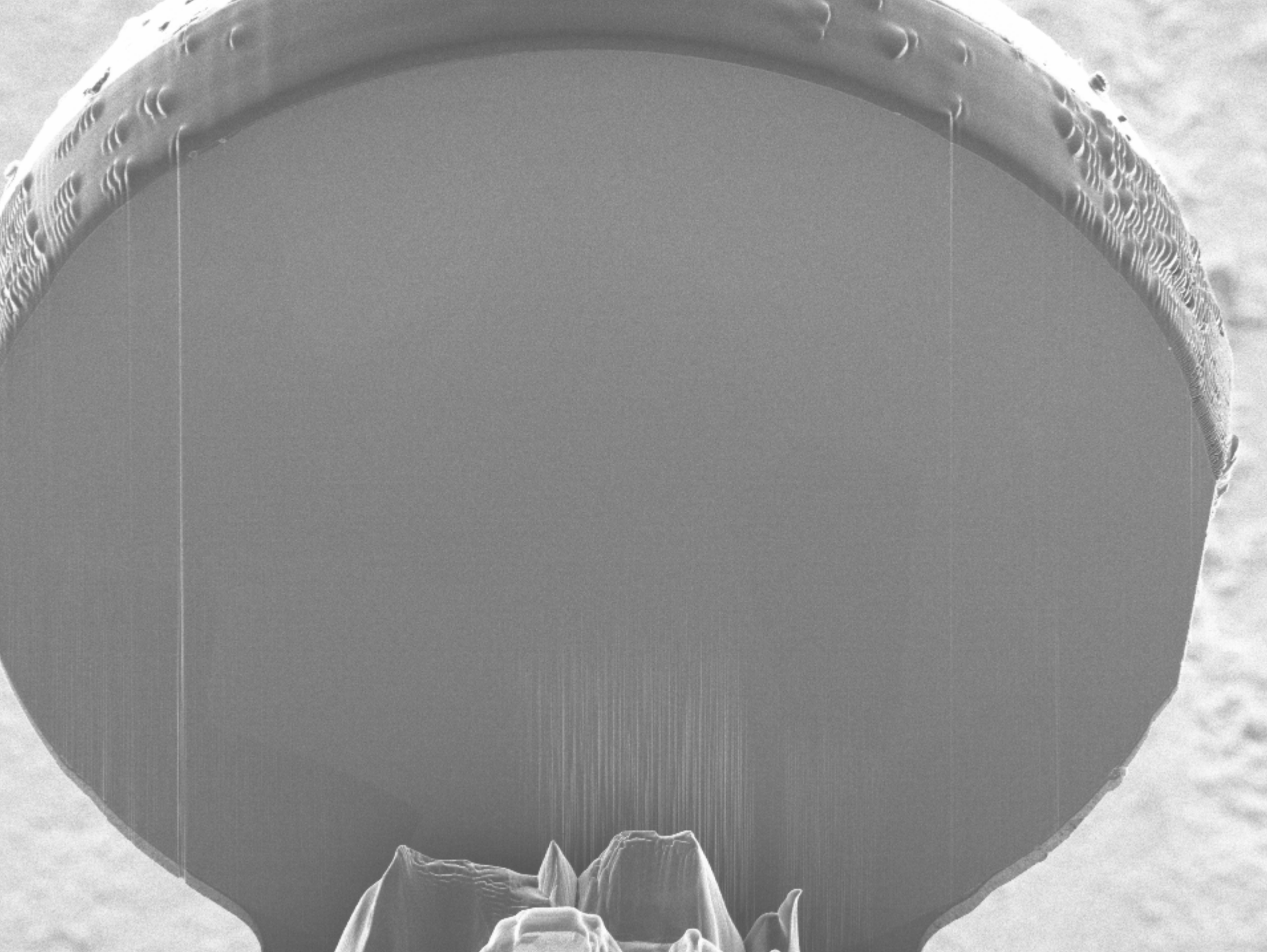
A Mg particle is mounted onto the edge of the TEM grid using an external lift-out tool

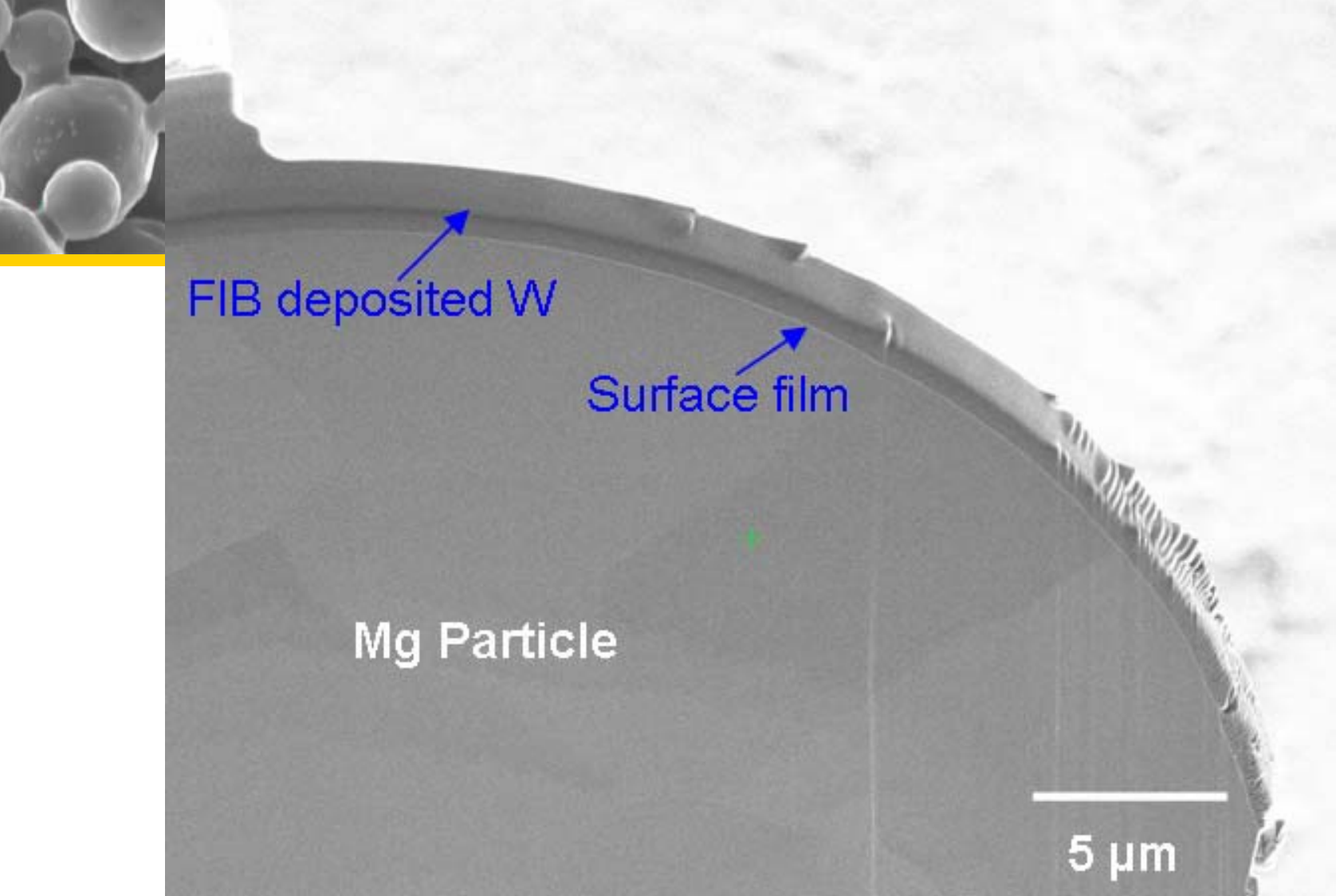












FIB secondary electron image showing the thin film formed on the Mg particle

STEM

W

Mg

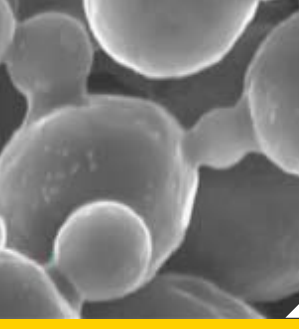
surface film

100 nm

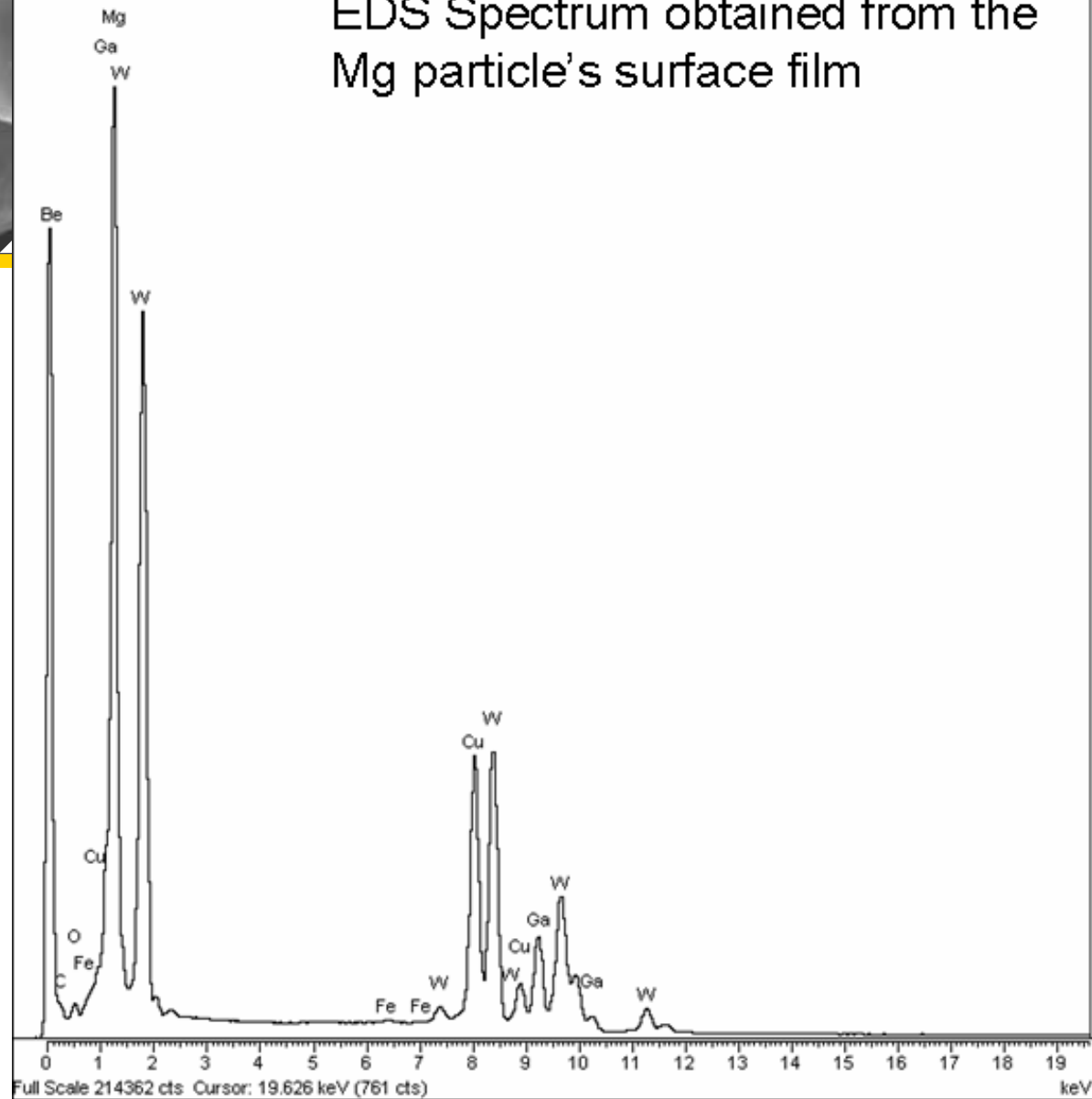


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## EDS Spectrum obtained from the Mg particle's surface film



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C



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Mg



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# Future Work

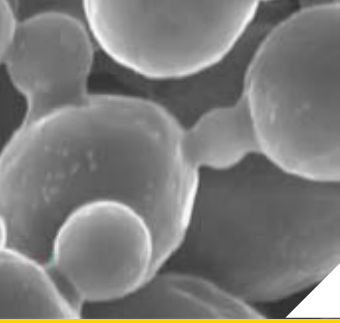
- Continue FIB/TEM and XPS to identify layer constituents and thickness
- Confirm findings with AES, SIMS
- Determine decomposition reactions by thermal analysis (DSC, DTA, TGA)
- Identify reduction mechanisms of Ca and Y
- Add alloying additions for liquid formation, strengthening and corrosion resistance





# Acknowledgments

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***Thank you***